Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/019,344	MULLER ET AL.	
Examiner	Art Unit	
Kristin Derwich	2132	

SEARCHED				
Class	Subclass	Date	Examiner	
380	46	7/20/2005	KD	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
·	DATE	EXMR
Searched EAST, see attached search history	7/20/2005	KD
Searched IEEE database, linear feedback shift register, smart card, side channel attacks, stuttering	7/21/2005	KD
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